36	earcn Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/816,409	TELLADO ET AL.	
Examiner	Art Unit	
Sam K. Ahn .	2611	

	SEARCHED					
Subclass	Date	Examiner				
130, 222, 149, 219, 346	1/26	an				
210,276,286						
2,40 ,01~ All ,16						
2	3/5	an				
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	130, 222, 149, 259, 346 210, 274, 286 289 289 240, 10	130, 222, 1/26 249, 229, 346 210, 276, 286 289 2,426,01~ 466,16				

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Class	Subclass	Date	Examiner
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